



SIGC18T60SNC

IGBT Chip in NPT-technology

FEATURES:

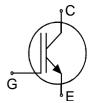
- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

This chip is used for:

• SGP20N60

Applications:

drives



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC18T60SNC	600V	20A	4.3 x 4.3 mm ²	sawn on foil	Q67041-S2856- A001
SIGC18T60SNC	600V	20A	4.3 x 4.3 mm ²	unsawn	Q67041-S2856- A002

MECHANICAL PARAMETER:

Raster size	4.3 x 4.3			
Area total / active	18.49 / 14.3			
Emitter pad size	2.48 x 2.98			
Gate pad size	0.7 x 1.08			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	270	deg		
Max.possible chips per wafer	796			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, ≤500μm			
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month			



SIGC18T60SNC

MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	20	Α
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	40	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i didilictei		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V _{GE} =0V, I _C =500μA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =20A	1.6	1.9	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=500\mu A, V_{GE}=V_{CE}$	3	4	5	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V			70	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V, V _{GE} =30V			120	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Onne
Input capacitance	Ciss	V _{CE} =25V	-	1100	1320	pF
Output capacitance	Coss	$V_{GE}=0V$	-	107	128	
Reverse transfer capacitance	Crss	f=1MHz	-	63	75	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

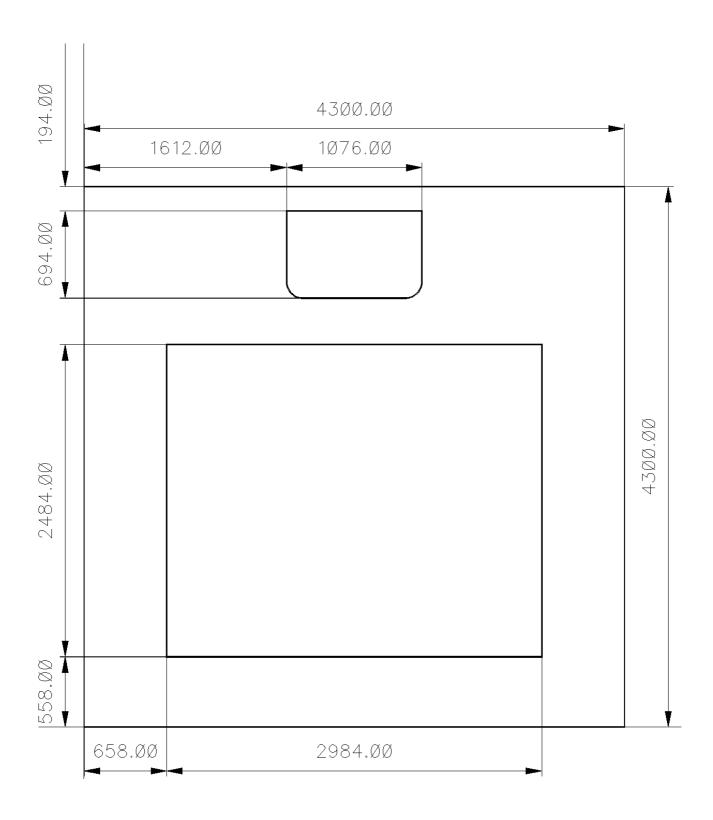
Parameter	Symbol	Conditions*	Value			I Init
rai ailietei			min.	typ.	max.	Unit
Turn-on delay time	$t_{d(on)}$	T _j =150°C	-	36	46	ns
Rise time	t _r	$V_{\rm CC}$ =400V $I_{\rm C}$ =20A	-	30	36	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ =+15/0V $R_{\rm G}$ =16 Ω	-	250	300	
Fall time	t _f	71G - 1022	-	63	76	

^{*} switching conditions different to 600V LowLoss, under comparable switching conditions 40% faster turnoff than LowLoss



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CHIP DRAWING:





Preliminary

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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet SGP20N60 Package :TO220

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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